



Sheet 1 of 1

FORM PTO-1449
(REV. 7-80)

U. S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF DOCUMENTS CITED BY APPLICANT
(Use several sheets if necessary)

ATTY. DOCKET NO.
NIT-163-02

APPLICANT
M. IWAYAMA et al

FILING DATE
February 15, 2002

SERIAL NO.
10/075,283

GROUP
2165 2165

U. S. PATENT DOCUMENTS

* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (// Appropriate)
	AA					
	AB					
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FOREIGN PATENT DOCUMENTS

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MAS	AL 10-269237	10/9/1998	Japan			<input checked="" type="checkbox"/>	<input type="checkbox"/>
	AM						
	AN						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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1/13/06

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Sheet 1 of 2

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M. IWAYAMA et alFILING DATE
February 15, 2002GROUP
265

U.S. PATENT DOCUMENTS

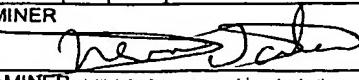
EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
MAJ	AA 5,590,319	12/31/96	Cohen et al			5-15-02
MPS	AB 5,987,460	11/1999	Niwa et al			5-15-02
WWD	AC 5,926,811	07/1999	Miller et al			5-15-02
WWD	AD 5,870,740	02/1999	Miller et al			5-15-02
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

MAJ	AR	B. Velez et al, "Fast and Effective Query Refinement", Annual International ACM-SIGIR Conference on Research and Development in Information Retrieval,
		US, New York, NY, July 27, 1997, pp. 6-15.
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M. IWAYAMA et alFILING DATE
February 15, 2002

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U.S. PATENT DOCUMENTS

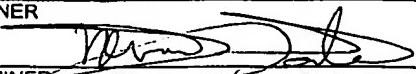
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FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIT-163-02	SERIAL NO. 10/075,283
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT M. IWAYAMA et al	
				FILING DATE February 15, 2002	GROUP 275-165

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
MP	AA 5,590,319	12/31/96	Cohen et al			
	AB 5,987,460	11/1999	Niwa et al			
	AC 5,926,811	07/1999	Miller et al			
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Technology Center 2100

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		US, New York, NY, July 27, 1997, pp. 6-15.
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EXAMINER <i>David J. Allen</i>	DATE CONSIDERED 1/5/06
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Sheet 2 of 2

FORM PTO-1449 (REV. 7-80)		DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. NIT-163-02	SERIAL NO. 10/675,283
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT M. IWAYAMA et al		
		FILING DATE February 15, 2002	GROUP 2165	

U.S. PATENT DOCUMENTS

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AP						<input type="checkbox"/> <input type="checkbox"/>

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EXAMINER <i>Howard Stiles</i>	DATE CONSIDERED 1/5/06
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